Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/681,823	HAWTHORNE ET AL.	
Examiner	**Art Unit**	
Jafar Parsa	1621	

SEARCHED			
Class	Subclass	Date	Examiner
422	49, 146, 147, 200, 201	1/22/2006	JP
165	86	1/22/2006	JP
165	104.16	1/22/2006	JP
165	104.18	1/22/2006	JP
518	728	1/22/2006	JP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
422	**49, 146**	1/22/2006	**JP**
422	200, 201	1/22/2006	JP
165	104.16	1/22/2006	JP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	1/22/2006	JP
inventor name search	1/22/2006	JP

Search Notes (continued)

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10/681,823	HAWTHORNE ET AL.	
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INTERFERENCE SEARCHED			
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165	**104.18**	1/22/2006	**JP**
518	728	1/22/2006	JP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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